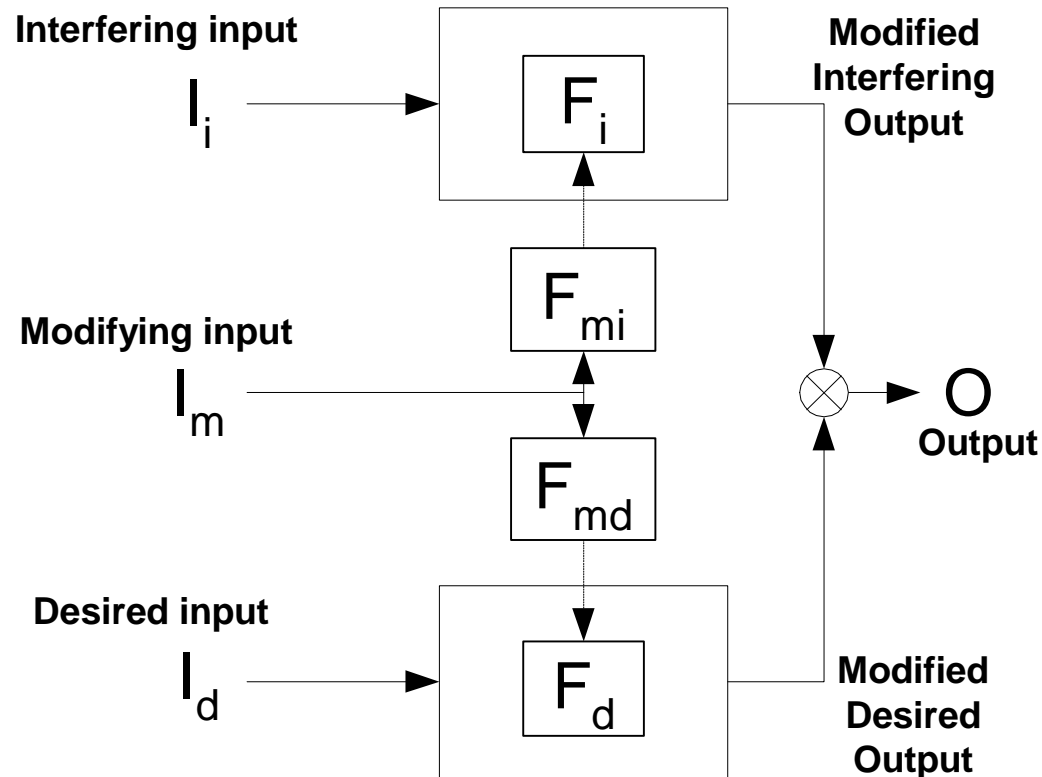


Compensation for Interfering and Modifying Inputs

- ● Methods of compensation
 - Inherent insensitivity
 - eg. Shielding instrument from EMI
 - Construction of strain gauges from invar
 - High Gain feedback
 - Calculated output corrections
 - Filtering
 - Opposing inputs

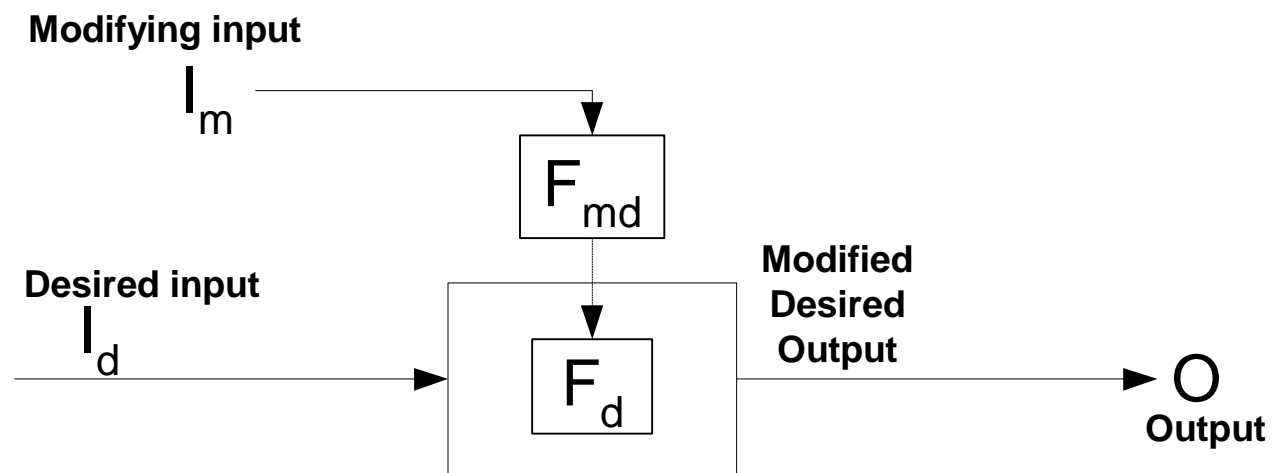
Method of inherent insensitivity

- Minimize F_i , F_{mi} , F_{md}
- Selectivity - ability to of an instrument to select the input of interest and reject interference signals



Method of high gain feedback

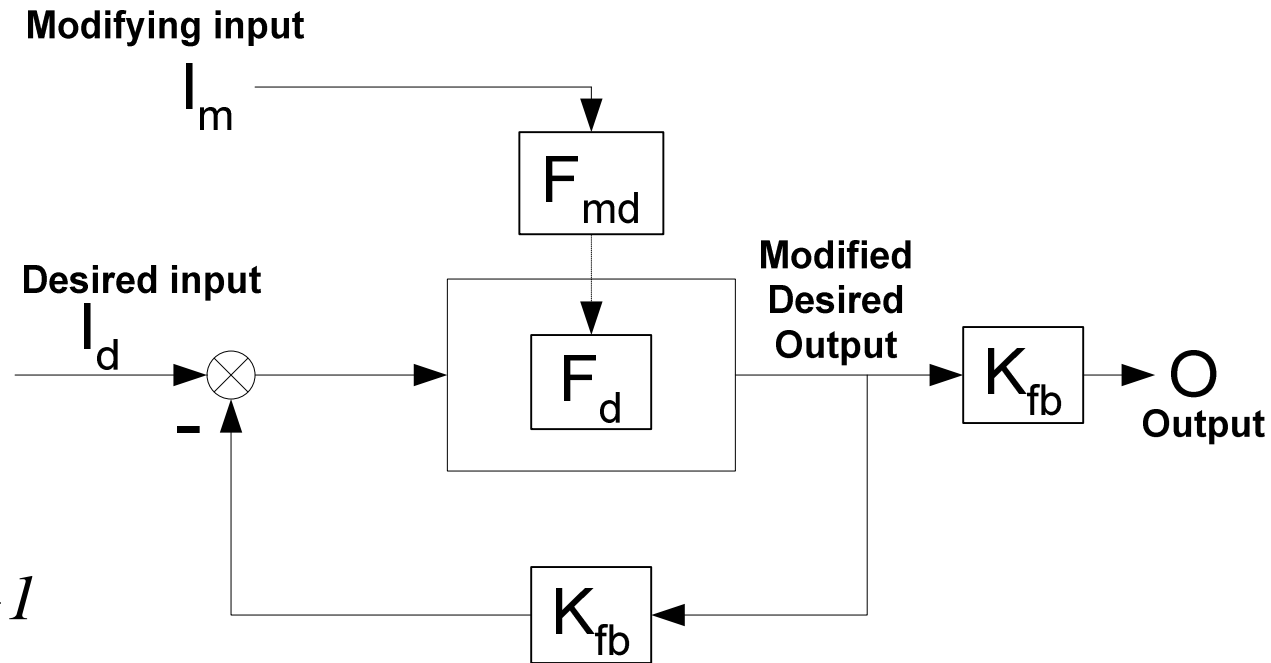
- System with modifying input



$$O = I_d F_d (I_m)$$

Method of high gain feedback

- Feedback loop added



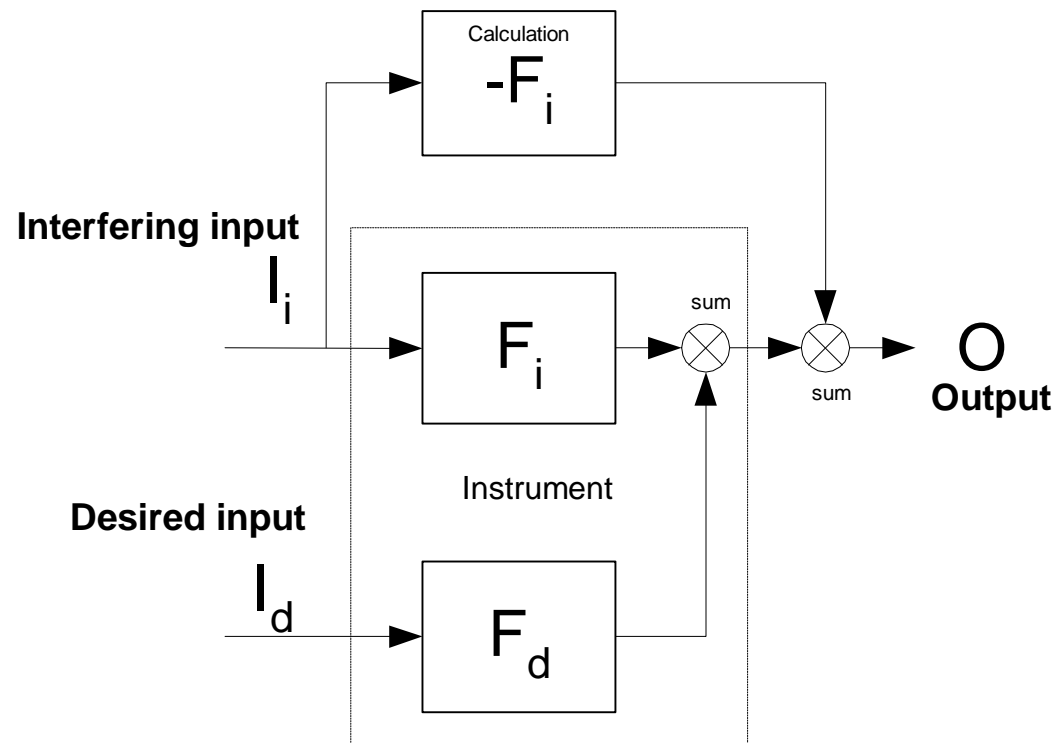
- $K_{fb} \gg 1$

$$O = \frac{I_d F_d(I_m) K_{fb}}{1 + K_{fb} F_d(I_m)} \cong \frac{I_d F_d(I_m) K_{fb}}{K_{fb} F_d(I_m)} = I_d$$

- O is no longer a function of $F_d(I_m)$

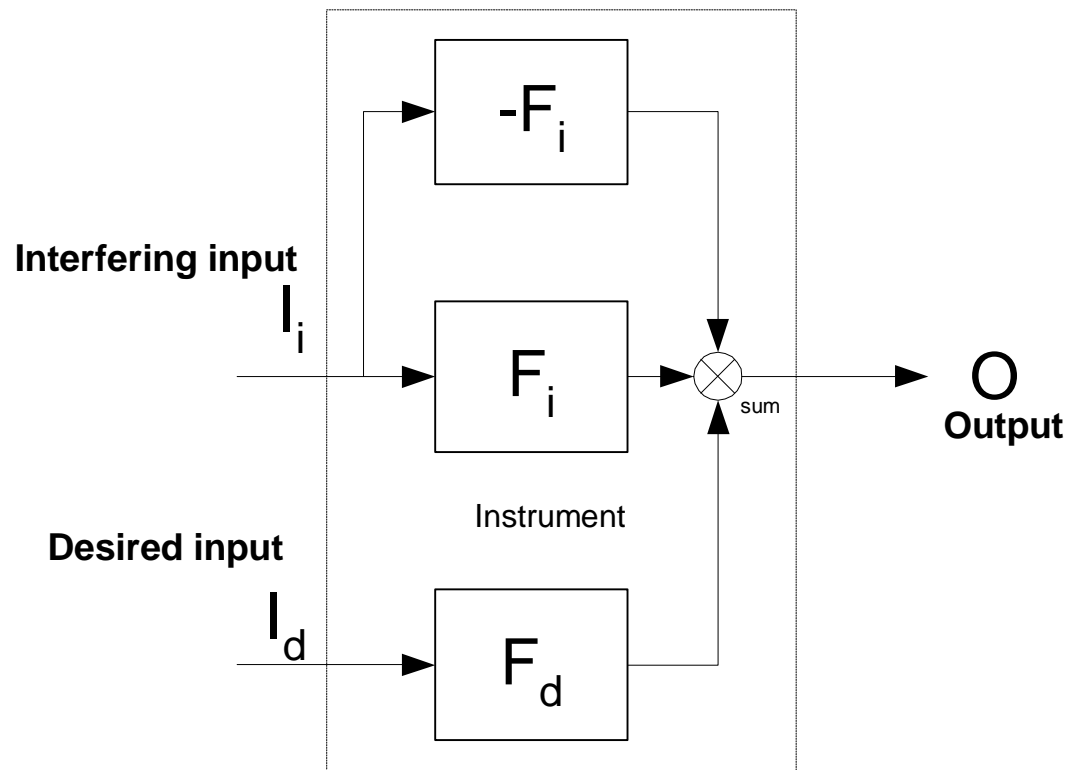
Method of calculated output correction

- Computer based systems allow correction to be made easily
- Requires that I_i be measured also



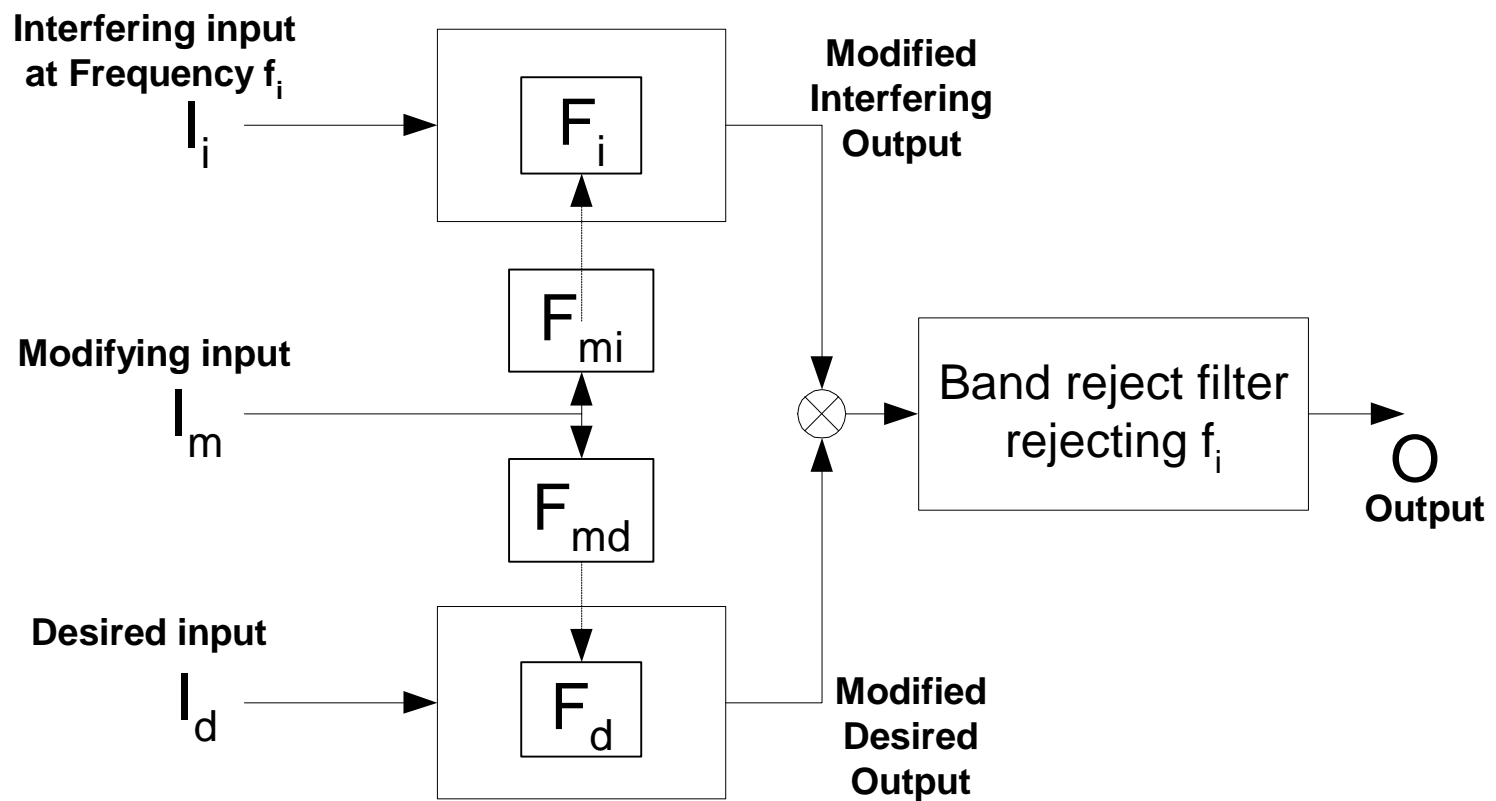
Method of Opposing Inputs

- Input information is used in some manner to form a correcting signal within the instrument



Method of filtering

- Removes interfering signal
 - Frequency of desired signal must be different from frequency of interference



Reporting Instrument Error

- NIST 1297
 - Standardizes the reporting of uncertainty
 - Coordinated with CIPM/ISO
 - Based on representing each component of uncertainty (u_i) in a measurement by an estimated standard deviation associated with that component. $u_i = \underline{\text{standard uncertainty}}$
 - Divides types of uncertainty into two categories
 - Type A - can be evaluated directly as a standard deviation
 - Type B - must be estimated in non-statistical fashion, but is expressed as a standard deviation
 - Assumes a correction factor is applied to remove systematic error (bias is removed by calibration)
 - Defines combined uncertainty (u_c) as the RMS of the component uncertainties:

$$u_c = \sqrt{\sum_i (u_i)^2}$$

NIST 1297 -cont-

– Note: $u_i = \frac{\partial u}{\partial x_i} x_i$

and

$$u_c = \sqrt{\sum_i \left(\frac{\partial u_i}{\partial x_i} x_i \right)^2}$$

- Defines expanded uncertainty, U , as the range within which the “value of the measurand”(Y) can confidently be expected to lie. And expanded uncertainty can be calculated as a product of coverage factor (k), and combined uncertainty (u_c)

$$U = ku_c$$

$$Y = y \pm U = y \pm ku_c$$

- Y- measurand, y - measurement result

NIST 1297 -cont-

- — Recommends use of a coverage factor of 2 (This is equivalent to ± 2 standard deviations or 95% if normal) or an explanation why.

Traceability of measurand and uncertainty

- A traceable measurand is not needed for determination of uncertainty.
 - Correction of systematic error or bias is assumed
 - Standard deviation of y given a single Y allows $u(y)$ to be determined

